Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/606,794	BUGE ET AL.		
Examiner	Art Unit		
Thu Khanh T. Nguyen	1722		

	SEARCHED					
Class	Subclass	Date	Examiner			
425	182, 186,	3/20/2006	TN			
425	330, 441	3/20/2006	TN			
425	443, 450	3/20/2006	TN			
425	451	3/20/2006	TN			
425	451.5	3/20/2006	TN			
425	468	3/20/2006	TN			

INT	ITERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
425	182, 186	3/20/2006	TN		
425	330, 441	3/20/2006	TN		
425	451.5	3/20/2006	TN		
	See interference search notes		TN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
Inventor search		3/20/2006	TN	
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